

Standard SCRs, 20A

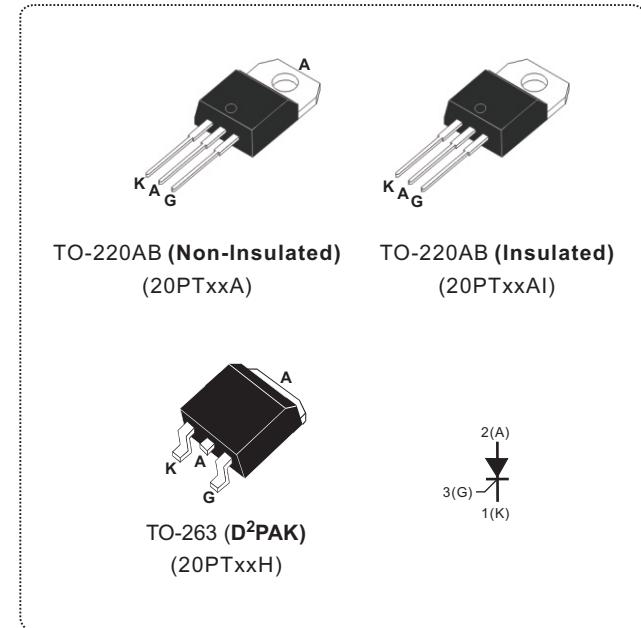
Main Features

Symbol	Value	Unit
$I_{T(RMS)}$	20	A
V_{DRM}/V_{RRM}	600 to 1000	V
I_{GT}	3 to 25	mA

DESCRIPTION

The 20PT series of silicon controlled rectifiers are high performance glass passivated technology, and are suitable for general purpose applications.

Using clip assembly technology, they provide a superior performance in surge current capabilities.



ABSOLUTE MAXIMUM RATINGS					
PARAMETER	SYMBOL	TEST CONDITIONS		VALUE	UNIT
RMS on-state current full sine wave (180° conduction angle)	$I_{T(RMS)}$	TO-263/TO-220AB	$T_C=100^\circ C$	20	A
		TO-220AB insulated	$T_C=80^\circ C$		
Average on-state current (180° conduction angle)	$I_{T(AV)}$	TO-263/TO-220AB	$T_C=100^\circ C$	13	A
		TO-220AB insulated	$T_C=80^\circ C$		
Non repetitive surge peak on-state current (full cycle, T_j initial = 25°C)	I_{TSM}	$F=50$ Hz	$t=20$ ms	200	A
		$F=60$ Hz	$t=16.7$ ms	220	
I^2t Value for fusing	I^2t	$t_p=10$ ms		200	A^2s
Critical rate of rise of on-state current $I_G = 2xI_{GT}$, $t_r \leq 100$ ns	dI/dt	$F=60$ Hz	$T_j = 125^\circ C$	50	$A/\mu s$
Peak gate current	I_{GM}	$T_p = 20$ μs	$T_j = 125^\circ C$	4	A
Maximum gate power	P_{GM}	$T_p = 20\mu s$	$T_j = 125^\circ C$	10	W
Average gate power dissipation	$P_{G(AV)}$	$T_j = 125^\circ C$		1	W
Repetitive peak off-state voltage	V_{DRM}	$T_j = 125^\circ C$		600 to 1000	V
Repetitive peak reverse voltage	V_{RRM}				
Storage temperature range	T_{stg}			- 40 to + 150	$^\circ C$
Operating junction temperature range	T_j			- 40 to + 125	

ELECTRICAL SPECIFICATIONS ($T_J = 25^\circ\text{C}$ unless otherwise specified)					
SYMBOL	TEST CONDITIONS	20PTxxxx		Unit	
		D	-		
I_{GT}	$V_D = 12V$, $R_L = 33\Omega$	Min.	4	3	mA
		Max.	10	25	
V_{GT}		Max.	1.3	1.3	V
V_{GD}	$V_D = V_{DRM}$, $R_L = 3.3\text{K}\Omega$ $R_{GK} = 220\Omega$	$T_J = 125^\circ\text{C}$	Min.	0.2	0.2
I_H	$I_T = 500\text{mA}$, Gate open		Max.	10	40
I_L	$I_G = 1.2 \times I_{GT}$		Min.	20	60
dV/dt	$V_D = 67\% V_{DRM}$, Gate open	$T_J = 125^\circ\text{C}$	Min.	100	500
V_{TM}	$I_T = 40\text{A}$, $t_P = 380\mu\text{s}$	$T_J = 25^\circ\text{C}$	Max.	1.6	V
I_{DRM} I_{RRM}	$V_D = V_{DRM}$, $V_R = V_{RRM}$ $R_{GK} = 220\Omega$	$T_J = 25^\circ\text{C}$	Max.	5	μA
		$T_J = 125^\circ\text{C}$	Max.	2	mA
V_{to}	Threshold Voltage	$T_J = 125^\circ\text{C}$	Max.	0.77	V
R_d	Dynamic Resistance	$T_J = 125^\circ\text{C}$	Max.	23	$\text{m}\Omega$

THERMAL RESISTANCE					
SYMBOL	Parameter			VALUE	UNIT
$R_{th(j-c)}$	Junction to case (DC)		$D^2\text{PAK}/\text{TO}-220\text{AB}$	1.05	$^\circ\text{C}/\text{W}$
			TO-220AB insulated	2.1	$^\circ\text{C}/\text{W}$
$R_{th(j-a)}$	Junction to ambient	$S = 1 \text{ cm}^2$	TO-263($D^2\text{PAK}$)	45	
			TO-220AB/TO-220AB insulated	60	

S=Copper surface under tab

PRODUCT SELECTOR					
PART NUMBER	VOLTAGE (xx)			SENSITIVITY	PACKAGE
	600 V	800 V	1000 V		
20PTxxA/20PTxxAI	V	V	V	25 mA	TO-220AB
20PTxxH	V	V	V	25 mA	$D^2\text{PAK}$
20PTxxA-D / 20PTXXAI-D	V	V	X	4-10 mA	TO-220AB
20PTxxH-D	V	V	X	4-10 mA	$D^2\text{PAK}$

ORDERING INFORMATION					
ORDERING TYPE	MARKING	PACKAGE	WEIGHT	BASE Q'TY	DELIVERY MODE
20PTxxA/20PTxxA-D	20PTxxA/20PTxxA-D	TO-220AB	2.0g	50	Tube
20PTxxAI/20PTxxAI-D	20PTxxAI/20PTxxAI-D	TO-220AB (insulated)	2.3g	50	Tube
20PTxxH/20PTxxH-D	20PTxxH/20PTxxH-D	TO-263($D^2\text{PAK}$)	2.0g	50	Tube

Note: xx = voltage

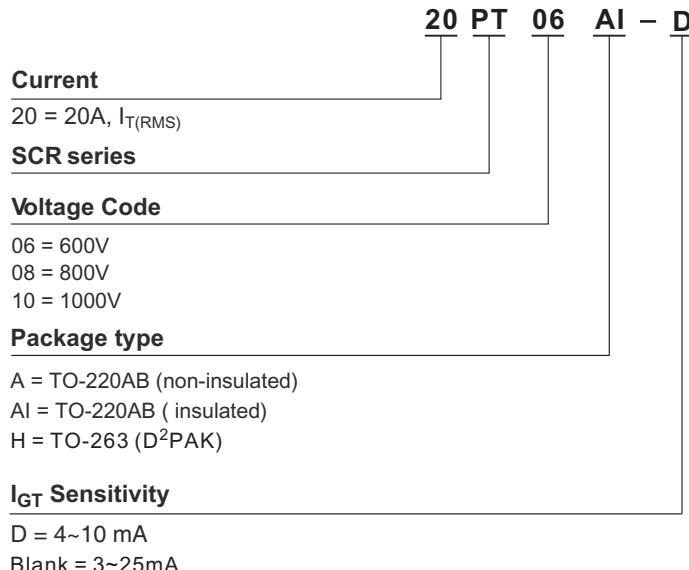
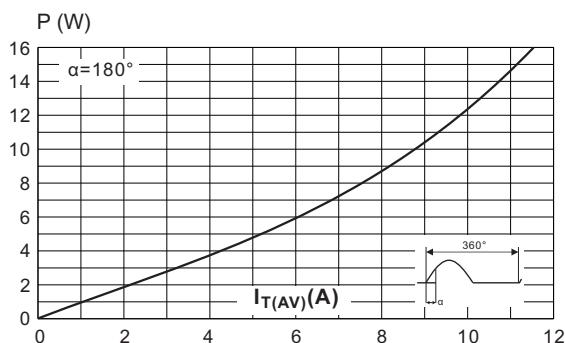
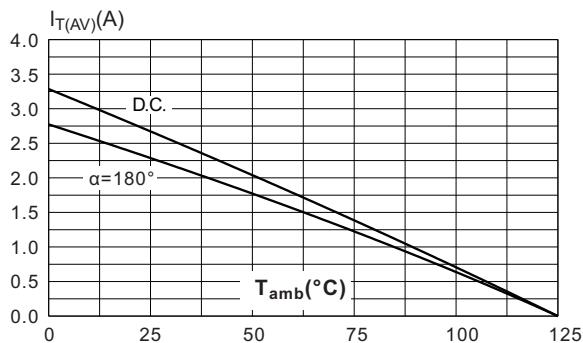
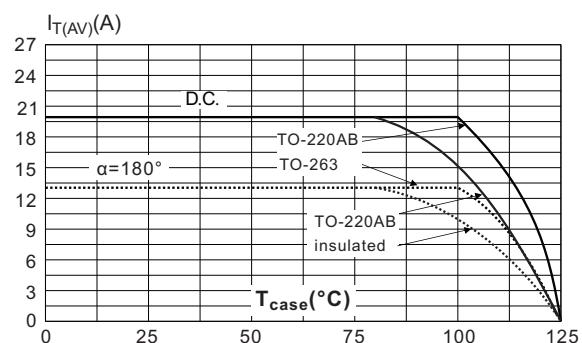
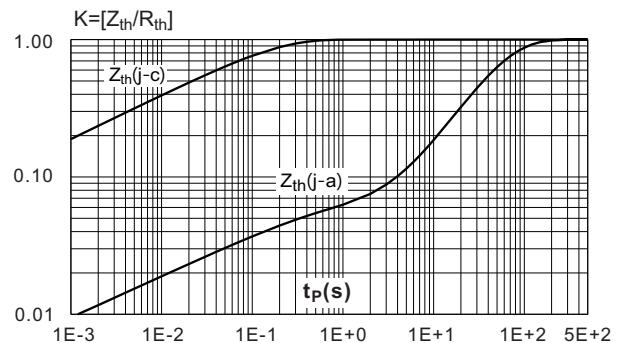
ORDERING INFORMATION SCHEME

Fig.1 Maximum average power dissipation versus average on-state current.

Fig.3 Average and D.C. on-state current versus ambient temperature. (copper surface under tab: $S=1\text{cm}^2$) (D²PAK)

Fig.2 Average and D.C. on-state current versus case temperature.

Fig.4 Relative variation of thermal impedance versus pulse duration.


Fig.5 Relative variation of gate trigger current, holding current and latching current and latching current versus junction temperature.

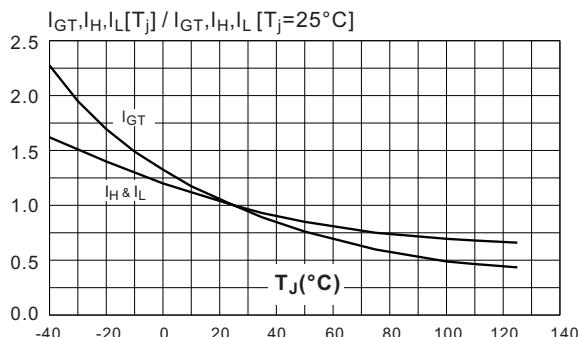


Fig.6 Surge peak on-state current versus number of cycles.

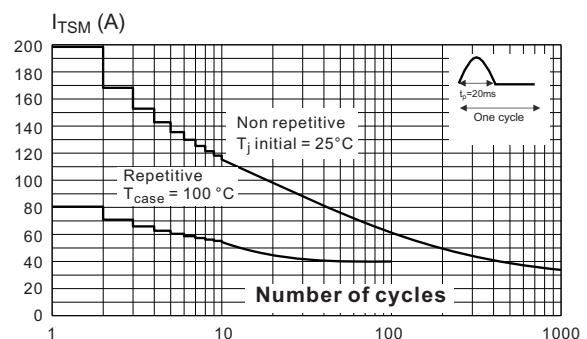


Fig.7 Non-repetitive surge peak on-state current for a sinusoidal pulse with width $t_p < 10$ ms, and corresponding values of I^2t

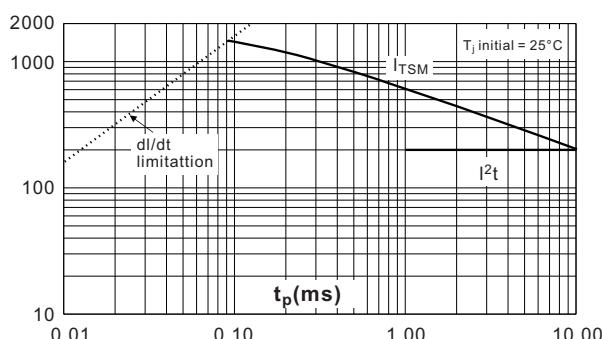


Fig.8 On-state characteristics (maximum values)

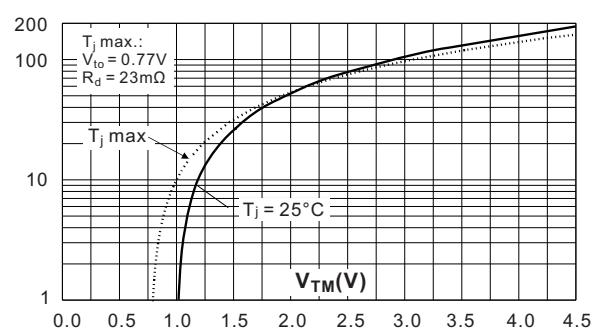
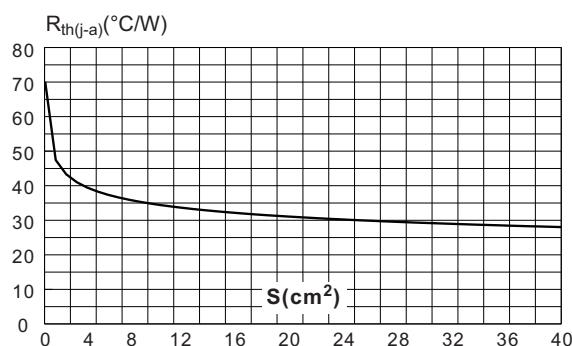
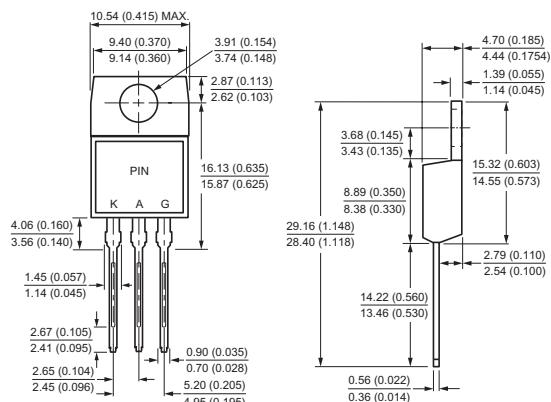
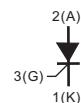
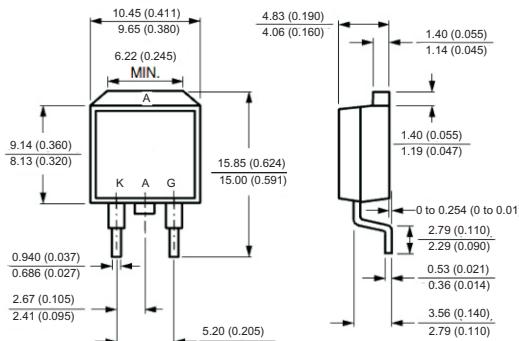


Fig.9 Thermal resistance junction to ambient versus copper surface under tab (epoxy printed circuit board Fr4, copper thickness:35 µm)(D²PAK)



Case Style

TO-220AB

TO-263(D²PAK)


All dimensions in millimeters(inches)